



SLF750U 430V N-Channel MOSFET

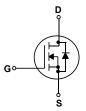
General Description

This Power MOSFET is produced using Msemitek's advanced planar stripe DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, active power factor correction based on half bridge topology.

Features

- N-Channel:430V 11A $R_{DS(on)Typ} = 0.54\Omega@V_{GS} = 10 \text{ V}$
- Very Low On-resistance RDS(ON)
- LowCrss
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability





Absolute Maximum Ratings T_C = 25°C unless otherwise noted

| Symbol | Parameter | SLF750U | Units |
|-----------------------------------|---|-------------|-------|
| V _{DSS} | Drain-Source Voltage | 430 | V |
| | Drain Current - Continuous (T _C = 25°C) | 11 | Α |
| l _D | - Continuous (T _C = 100°C) | 6.7 | Α |
| I _{DM} | Drain Current - Pulsed (Note 1) | 33 | Α |
| V_{GSS} | Gate-Source Voltage | ±30 | V |
| Eas | Single Pulsed Avalanche Energy | 437 | mJ |
| P _D | Power Dissipation (T _C = 25°C) | 35 | W |
| Rejc | Thermal Resistance, Junction to Case | 3.57 | °C/W |
| T _J , T _{STG} | Operating and Storage Temperature Range | -55 to +150 | °C |
| T∟ | Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds | 300 | °C |

^{*} Drain current limited by maximum junction temperature.

Package Marking

Symbol

 I_{GSSR}

| Part Number | Top Marking | Package | Packing Method | MOQ | QTY | |
|-------------|-------------|---------|----------------|------|------|--|
| SLF750U | SLF750U | TO-220F | Tube | 1000 | 5000 | |

Electrical Characteristics

Parameter

Gate-Body Leakage Current, Reverse

T_C = 25°C unless otherwise noted

Test Conditions

Min

Тур

Max

-100

Units

nΑ

| | Off Characteristics | | | | | | | | |
|--|---------------------|--|--|-----|--|-----|----|--|--|
| | BV _{DSS} | Drain-Source Breakdown Voltage | V _{GS} = 0 V, I _D = 250 uA | 430 | | | V | | |
| | l | I _{DSS} Zero Gate Voltage Drain Current | V _{DS} =400 V, V _{GS} = 0 V | 1 | | 1 | uA | | |
| | IDSS | | V _{DS} = 340V, T _C = 125°C | 1 | | 10 | uA | | |
| | Icee | Gate-Body Leakage Current Forward | $V_{cs} = 30 \text{V} V_{bs} = 0 \text{ V}$ | | | 100 | nΑ | | |

 V_{GS} = -30 V, V_{DS} = 0 V

On Characteristics

| V _{GS(th)} | Gate Threshold Voltage | $V_{DS} = V_{GS}$, $I_D = 250 \text{ uA}$ | 2 | 1 | 4 | V |
|---------------------|--------------------------------------|---|---|------|------|---|
| R _{DS(on)} | Static Drain-Source On-Resistance | V _{GS} = 10 V, I _D =5.5 A | - | 0.54 | 0.64 | Ω |

Dynamic Characteristics

| | C_{iss} | Input Capacitance | | | 835 | - | pF |
|---|-----------|------------------------------|--|---|------|---|----|
| | Coss | Output Capacitance | V _{DS} =25 V, V _{GS} = 0 V, f = 1.0 MHz | - | 98 | - | pF |
| I | C_{rss} | Reverse Transfer Capacitance | | - | 3.85 | - | pF |

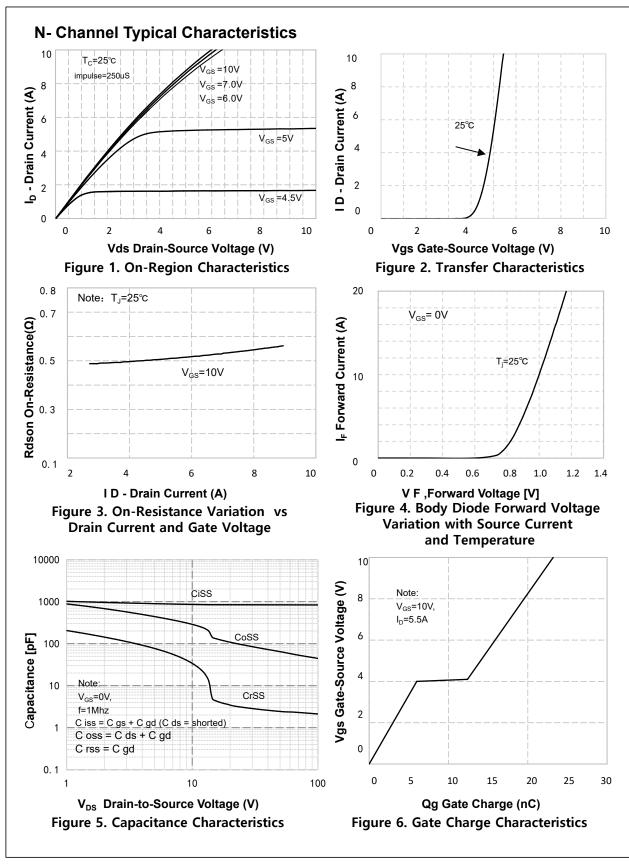
Switching Characteristics

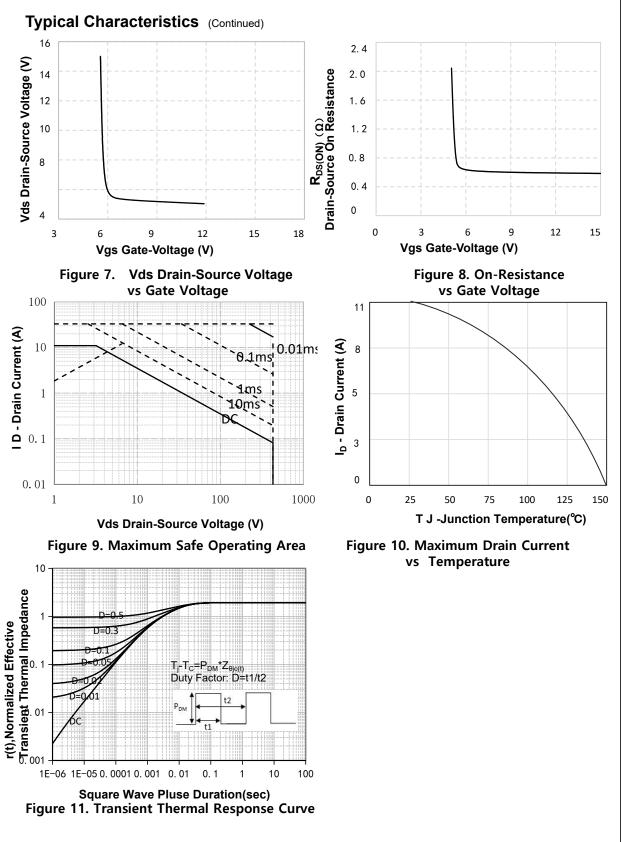
| $t_{d(on)}$ | Turn-On Delay Time | V_{DS} = 210V, R_{G} = 25 Ω , I_{D} =5.5A | - | 19 | | ns |
|----------------|---------------------|--|---|-----|---|----|
| tr | Turn-On Rise Time | | - | 70 | - | ns |
| $t_{d(off)}$ | Turn-Off Delay Time | | - | 70 | - | ns |
| t _f | Turn-Off Fall Time | | | 27 | | ns |
| Q_g | Total Gate Charge | V _{DS} = 210V, I _D =5.5A, V _{GS} = 10V | - | 23 | | nC |
| Q_gs | Gate-Source Charge | | - | 5.4 | - | nC |
| Q_{gd} | Gate-Drain Charge | | - | 5 | | nC |

Drain-Source Diode Characteristics and Maximum Ratings

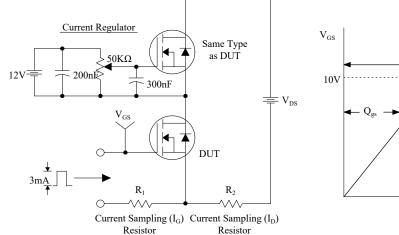
| Is | Maximum Continuous Drain-Source Diode Forward Current | - | - | 11 | Α |
|-----------------|---|---|-----|-----|----|
| I _{SM} | Maximum Pulsed Drain-Source Diode Forward Current | - | 1 | 33 | Α |
| V _{SD} | Drain to Source Diode Forward Voltage, V GS = 0V, I SD = 11A, T J = 25°C | - | 1 | 1.4 | V |
| t _{rr} | Reverse Recovery Time &T _J = 25°C, IF = 5.5A di/dt = 100A/µs | | 410 | - | nS |
| Qrr | Reverse Recovery Charge & T _J = 25°C, IF =5.5A di/dt = 100A/µs | | 7 | - | nC |

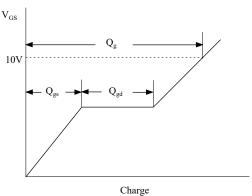
- 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
- 2. EAS condition: \bar{T}_J =25°C, V _{DD} =50V, V _G =10V, R_G =25 Ω , 3. Pulse Test: Pulse Width≤300 μ s, Duty Cycle≤0.5%



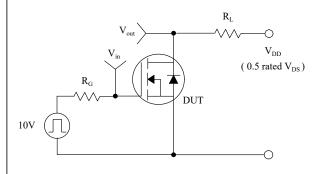


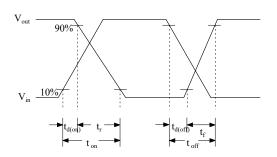
Gate Charge Test Circuit & Waveform



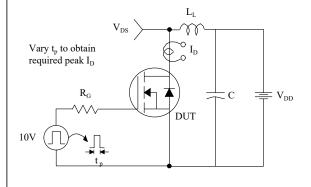


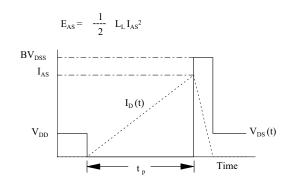
Resistive Switching Test Circuit & Waveforms



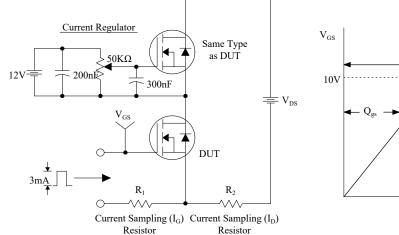


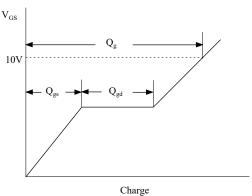
Unclamped Inductive Switching Test Circuit & Waveforms



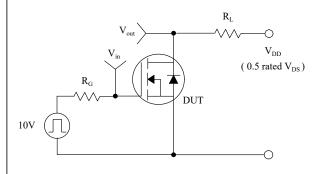


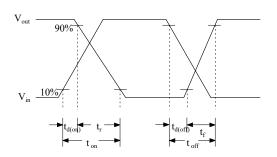
Gate Charge Test Circuit & Waveform



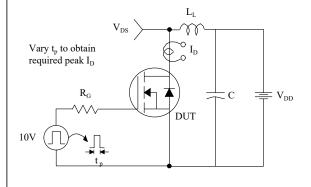


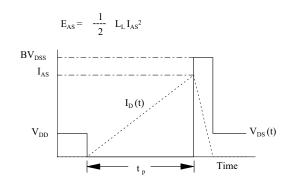
Resistive Switching Test Circuit & Waveforms



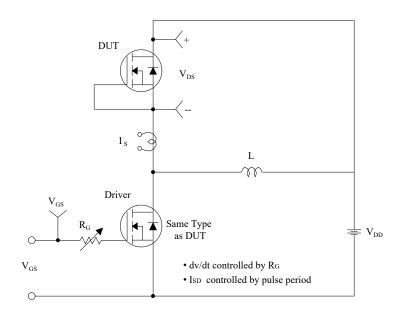


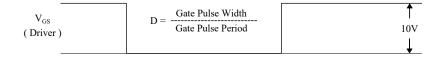
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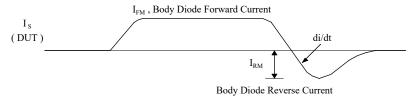


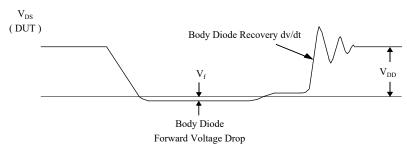


Peak Diode Recovery dv/dt Test Circuit & Waveforms

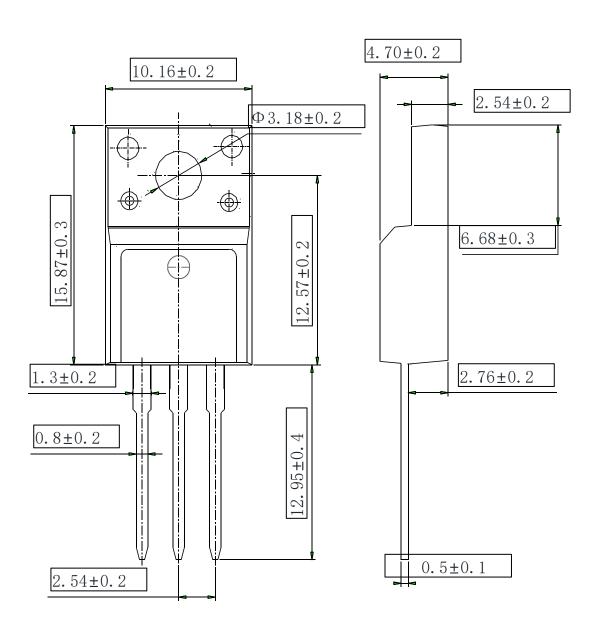








TO-220F OUTLINE



NOTE:

1The plastic package is not marked as smooth surfaceRa=0.1; Subglossy surfaceRa=0.8 2. Undeclared tolerance \pm 0.15, Unmarked filletRmax=0.25

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